Search Notes

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Applicant(s)/Patent Unde Reexamination

10591016 SANO ET AL.

Examiner Art Unit

STEPHAN ESSEX 1795

SEARCHED

Class	Subclass	Date	Examiner
429	40, 41, 42, 43, 44	7/17/2009	SJE
502	101	7/17/2009	SJE

SEARCH NOTES

Search Notes	Date	Examiner
EAST see search history	7/17/2009	SJE
Inventor search	7/17/2009	SJE
Consulted Dah-Wei Yuan and Jonathan Crepeau	7/17/2009	SJE
Updated EAST search, see search history	1/15/2010	SJE
Consulted Dah-Wei Yuan	1/15/2010	SJE

INTERFERENCE SEARCH Class Subclass Date Examiner

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